Search Notes



Application/Control No.	Appl	icat	ion/	Con	trol	No.
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10533115

Applicant(s)/Patent Under Reexamination

TAKAYAMA ET AL.

Examiner

Art Unit

Wang, Chang-Yu

1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST, STN: search strategy attached (updated).	4/02/09	CYW	
Inventor name search: EAST, STN, PALM (updated). 4/02/09 CYW		CYW	
PLUS search from STIC. see search results in eDAN (02/17/09) 4/02/09 CYW			

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

/C.Y. W./ Examiner.Art Unit 1649	

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